S	earcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/849,605	SCHIRMER ET AL.	
Examiner	Art Unit	
Helen C. Kwok	2856	

	SEARCHED		
Class	Subclass	Date	Examiner
			<u>.</u>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
73	493	8/1/2006	нк
73	866.5	8/1/2006	нк
73	654	8/1/2006	нк

SEARCH I (INCLUDING SEAR		()
	DATE	EXMR
Updated Previous Search	8/1/2006	НК